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FDC655BN Single N-Channel, Logic Level, PowerTrench[®] MOSFET 30 V, 6.3 A, 25 m Ω

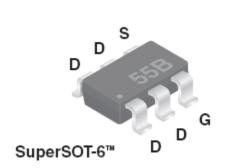
Features

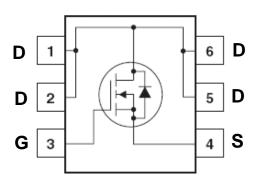
- Max $r_{DS(on)} = 25 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}, I_D = 6.3 \text{ A}$
- Max $r_{DS(on)}$ = 33 m Ω at V_{GS} = 4.5 V, I_D = 5.5 A
- Fast switching
- Low gate charge
- High performance trchnology for extremely low r_{DS(on)}
- Termination is Lead-free and RoHS Compliant

General Description

This N-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter				Ratings		Units
V _{DS}	Drain to Source Voltage			30		V	
V _{GS}	Gate to Source Voltage			±20		V	
		-Continuous	$T_A = 25^{\circ}C$	(Note 1a)	6.3		•
I _D	-Pulsed				20		A
P _D	Power Dis	ssipation		(Note 1a)	1.6	W	
	Power Dis	ssipation		(Note 1b)	0.8		
T _J , T _{STG}	Operating and Storage Junction Temperature Range				-55 to + 15	0	°C
Thermal Cl	naracteris	tics					1
Thermal Cl		rtics Resistance, Junction to	Ambient	(Note 1a)	78		°C/M
R _{θJA}	Thermal I	Resistance, Junction to		(Note 1a)	78		°C/W
R _{θJA}	Thermal F arking an			(Note 1a)	78 Tape Width	Qua	°C/W

January 2010

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	30			V
ΔBV _{DS} S ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$, referenced to $25^{\circ}C$		25		mV/°C
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 V, V_{DS} = 0 V$			±100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25°C		-5		mV/°C
	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 6.3 A		21	25	
r _{DS(on)}		$V_{GS} = 4.5 V, I_{D} = 5.5 A$		26	33	mΩ
20(01)		V _{GS} = 10 V, I _D = 6.3 A, T _J = 125°C		30	36	I
		$v_{\rm GS} = 10^{-1}$, $v_{\rm S} = 0.3^{-1}$, $v_{\rm S} = 123^{-1}$		50	50	
9 _{FS}	Forward Transconductance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 0.3 \text{ A}, \text{ I}_{J} = 123 \text{ C}$ $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$		35		S
Dynamic	Characteristics			35		
Dynamic C _{iss}	Characteristics Input Capacitance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ 		35 470	620	pF
Dynamic C _{iss} C _{oss}	Characteristics Input Capacitance Output Capacitance	V _{DS} = 10 V, I _D = 6.3 A		35 470 100	620 130	pF pF
Dynamic C _{iss} C _{oss} C _{rss}	Characteristics Input Capacitance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ 		35 470	620	pF
Dynamic C _{iss} C _{oss} C _{rss} R _g	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ 		35 470 100 60	620 130	pF pF pF
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ 		35 470 100 60	620 130	pF pF pF
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHz		35 470 100 60 3.0	620 130 90	pF pF pF Ω
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching t _{d(on)} t _r	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ 		35 470 100 60 3.0 6	620 130 90 11	pF pF pF Ω ns
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHz $V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$		35 470 100 60 3.0 6 2	620 130 90 11 11	pF pF pF Ω ns
Dynamic C _{iss} C _{oss} Crss Rg Switching tr td(on) td td(off) tf	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHz $V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$		35 470 100 60 3.0 6 2 15	620 130 90 11 11 10 26	pF pF pF Ω ns ns
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching t _d (on) t _r t _d (off) t _f Q _g	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$ $V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V} \text{ V}_{DD} = 15 \text{ V},$		35 470 100 60 3.0 6 2 15 2	620 130 90 11 10 26 10	pF pF Ω ns ns ns ns
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching t _d (on) t _r	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$ $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$ $V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$		35 470 100 60 3.0 6 2 15 2 9	620 130 90 11 10 26 10 13	pF pF Ω ns ns ns ns nc

I _S	Maximum Continuous Drain-Source Diode Forward Current				1.3	А
V _{SD}	Source-Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 1.3 A (Note 2)	().8	1.2	V
t _{rr}	Reverse Recovery Time	I _E = 6.3 A, di/dt = 100 A/μs		15	26	ns
Q _{rr}	Reverse Recovery Charge	$= 160 \text{ A/} \mu \text{s}$		4	10	nC

Notes:

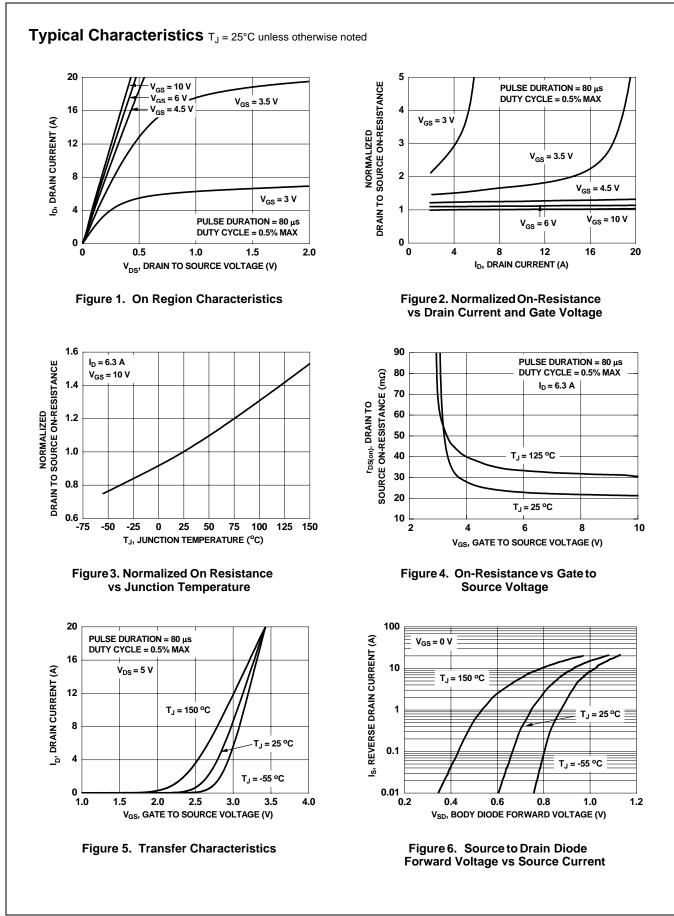
Downloaded from Arrow.com.

 $R_{0,LA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{0,LC}$ is guaranteed by design while $R_{0,CA}$ is determined by the user's board design.

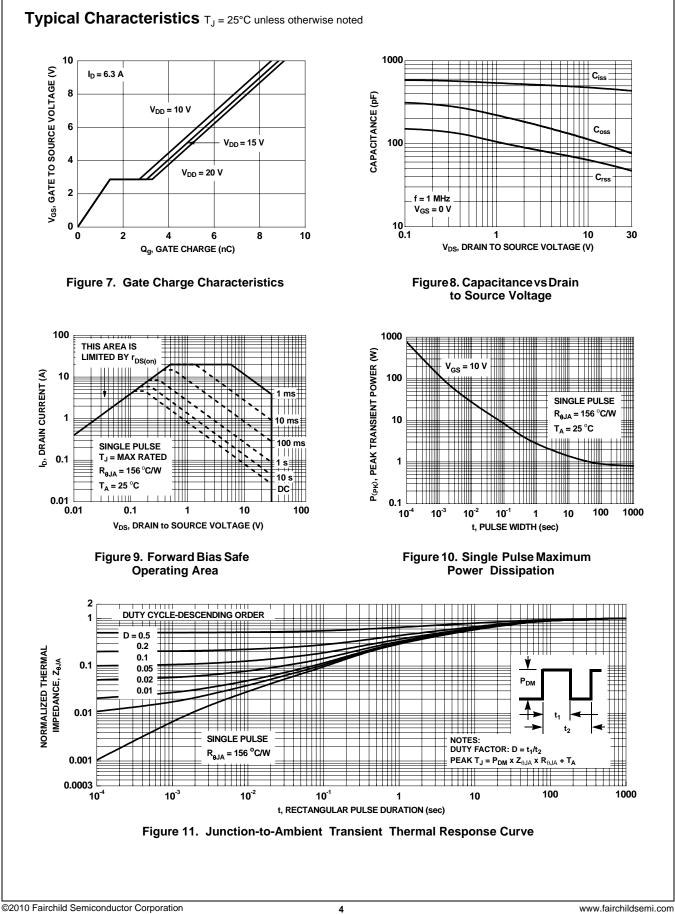
a. 78 °C/W when mounted on a 1 in² pad of 2 oz copper on FR-4 board. b. 156 °C/W when mounted on a minimum pad.

2: Pulse Test: Pulse Width<300 us, Duty Cycle<2.0%.

FDC655BN Single N-Channel, Logic Level, PowerTrench[®] MOSFET



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